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NPN wideband silicon germanium RF transistor

Rev. 2 — 16 January 2015

Product data sheet

1. Product profile

1.1 General description

NPN silicon germanium RF transistor for high speed, low noise applications in a plastic, 4-pin dual-emitter SOT343F package.

The BFU910F is suitable for small signal applications up to 20 GHz.

1.2 Features and benefits

- Low noise high gain microwave transistor
- Minimum noise figure (NF_{min}) = 0.65 dB at 12 GHz
- Maximum stable gain 14.2 dB at 12 GHz
- 90 GHz f_T SiGe technology

1.3 Applications

K_u band DBS Low-Noise blocks

1.4 Quick reference data

Table 1. Quick reference data

T_{amb} = 25 °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CE}	collector-emitter voltage	$R_{BE} \le 1 M\Omega$	-	2.0	3.0	٧
I _C	collector current		-	10	15	mA
P _{tot}	total power dissipation	$T_{sp} \le 90 ^{\circ}C$	-	-	300	mW
h _{FE}	DC current gain	I _C = 6 mA; V _{CE} = 2 V	-	1900	-	
C _{CBS}	collector-base capacitance	V _{CB} = 2 V; f = 1 MHz	-	35	-	fF
f _T	transition frequency	I _C = 6 mA; V _{CE} = 2 V	-	90	-	GHz
MSG	maximum stable gain	I _C = 6 mA; V _{CE} = 2 V; f = 12 GHz	-	14.2	-	dB
NF _{min}	minimum noise figure	I_C = 6 mA; V_{CE} = 2 V; f = 12 GHz; Γ_S = Γ_{opt}	-	0.65	-	dB
G _{ass}	associated gain	I_C = 6 mA; V_{CE} = 2 V; f = 12 GHz; Γ_S = Γ_{opt}	-	13.0	-	dB
P _{L(1dB)}	output power at 1 dB gain compression	I_C = 10 mA; V_{CE} = 2 V; f = 12 GHz; Z_S = Z_L = 50 Ω	-	2	-	dBm

^[1] T_{sp} is the temperature at the solder point of the emitter lead.



NPN wideband silicon germanium RF transistor

2. Pinning information

Table 2. Discrete pinning

Pin	Description	Simplified outline	Graphic symbol
1	emitter		
2	base	3 4	4
3	emitter		2 —
4	collector		.)
			1, 3
		2 1	mbb159

3. Ordering information

Table 3. Ordering information

Type number	Packag	Package			
	Name	Description	Version		
BFU910F	-	plastic surface-mounted flat pack package; reverse pinning; 4 leads	SOT343F		

4. Marking

Table 4. Marking

Type number	Marking	Description
BFU910F	F1*	* = t : made in Malaysia
		* = w : made in China

5. Design support

Table 5. Available design support

Download from the BFU910F product information page on http://www.nxp.com.

Support item	Available	Remarks
Device models for Agilent EEsof EDA ADS	Q1 2015	Based on Mextram device model.
SPICE model	Q1 2015	Based on Gummel-Poon device model.
S-parameters	yes	
Noise parameters	yes	
Solder pattern	yes	
Application notes	yes	

NPN wideband silicon germanium RF transistor

6. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CB}	collector-base voltage	open emitter	-	9.5	V
V_{CE}	collector-emitter voltage	open base	-	2.0	V
		shorted base	-	9.5	٧
V_{EB}	emitter-base voltage	open collector	-	1.5	V
T _{stg}	storage temperature		-65	+150	°C

7. Recommended operating conditions

Table 7. Characteristics

Symbol	Parameter	Conditions	Mi	n Ty	р Мах	Unit
V _{CE}	collector-emitter voltage	$R_{BE} \leq 1~M\Omega$	-	2.0	0 3.0	V
V_{EB}	emitter-base voltage	open collector	-	-	1.0	V
I _C	collector current		-	-	15	mA
Pi	input power	$Z_S = 50 \Omega$	-	-	0	dBm
Tj	junction temperature		-4	0 -	+150	°C
P _{tot}	total power dissipation	T _{sp} ≤ 90 °C	[1] -	-	300	mW

^[1] T_{sp} is the temperature at the solder point of the emitter lead.

8. Thermal characteristics

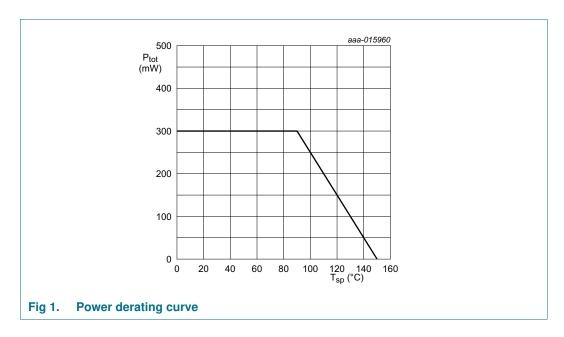
Table 8. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	[1][2]	202	K/W

^[1] T_{sp} is the temperature at the solder point of the collector lead. T_{sp} has the following relation to the ambient temperature T_{amb} : $T_{sp} = T_{amb} + P \times R_{th(sp-amb)}$ with P the power dissipation and $R_{th(sp-amb)}$ the thermal resistance between the solder point and ambient. $R_{th(sp-amb)}$ is determined by the heat transfer properties in the application. The heat transfer properties are set by the application board materials, the board layout and the environment e.g. housing.

[2] Based on simulation.

NPN wideband silicon germanium RF transistor



9. Characteristics

Table 9. Characteristics

 $T_{amb} = 25$ °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{(BR)CBO}	collector-base breakdown voltage	$I_C = 10 \mu A; I_E = 0 \mu A$	9.5	-	-	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	$I_C = 10 \mu A; I_B = 0 \mu A$	2.0	-	-	V
I _C	collector current		-	6	15	mA
h _{FE}	DC current gain	$I_C = 1.5 \text{ mA}; V_{CE} = 1.5 \text{ V}$	1200	2200	3300	
		I _C = 6 mA; V _{CE} = 2 V	-	1900	-	
C _{CES}	collector-emitter capacitance	V _{CE} = 2 V; f = 1 MHz	-	215	-	fF
C _{EBS}	emitter-base capacitance	V _{EB} = 0.5 V; f = 1 MHz	-	300	-	fF
C _{CBS}	collector-base capacitance	V _{CB} = 2 V; f = 1 MHz	-	35	-	fF
f _T	transition frequency	I _C = 5 mA; V _{CE} = 2 V	-	90	-	GHz
MSG	maximum stable gain	f = 10.7 GHz; V _{CE} = 2 V				
		I _C = 6 mA	-	15.2	-	dB
		I _C = 10 mA	-	15.5	-	dB
		f = 12 GHz; V _{CE} = 2 V				
		I _C = 6 mA	-	14.2	-	dB
		I _C = 10 mA	-	14.5	-	dB
		f = 12.75 GHz; V _{CE} = 2 V				
		I _C = 6 mA	-	14.2	-	dB
		I _C = 10 mA	-	14.5	-	dB

NPN wideband silicon germanium RF transistor

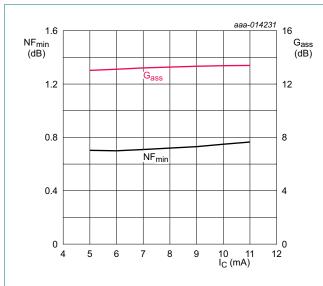
Table 9. Characteristics ...continued

T_{amb} = 25 °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
s ₂₁ ²	insertion power gain	f = 10.7 GHz; V _{CE} = 2 V				
		I _C = 6 mA	-	13.0	-	dB
		I _C = 10 mA	-	13.5	-	dB
		f = 12 GHz; V _{CE} = 2 V				
		I _C = 6 mA	-	12.0	-	dB
		I _C = 10 mA	-	12.5	-	dB
		f = 12.75 GHz; V _{CE} = 2 V				
		I _C = 6 mA	-	12.0	-	dB
		I _C = 10 mA	-	12.5	-	dB
NF _{min}	minimum noise figure	f = 10.7 GHz; V_{CE} = 2 V; Γ_{S} = Γ_{opt}				
		I _C = 6 mA	-	0.6	-	dB
		I _C = 10 mA	-	0.65	-	dB
		f = 12 GHz; V_{CE} = 2 V; Γ_{S} = Γ_{opt}				
		I _C = 6 mA	-	0.65	0.85	dB
		I _C = 10 mA	-	0.7	-	dB
		f = 12.75 GHz; V_{CE} = 2 V; Γ_{S} = Γ_{opt}				
		I _C = 6 mA	-	0.65	-	dB
		I _C = 10 mA	-	0.7	-	dB
G _{ass}	associated gain	$f = 10.7 \text{ GHz}; V_{CE} = 2 \text{ V}; \Gamma_{S} = \Gamma_{opt}$				
		I _C = 6 mA	-	13.5	-	dB
		I _C = 10 mA	-	14.0	-	dB
		f = 12 GHz; V_{CE} = 2 V; Γ_{S} = Γ_{opt}				
		I _C = 6 mA	-	13.0	-	dB
		I _C = 10 mA	-	13.5	-	dB
		f = 12.75 GHz; V_{CE} = 2 V; Γ_{S} = Γ_{opt}				
		I _C = 6 mA	-	13.0	-	dB
		I _C = 10 mA	-	13.5	-	dB
P _{L(1dB)}	output power at 1 dB gain compression	$ f = 12 \text{ GHz}; \text{ V}_{\text{CE}} = 2 \text{ V}; \text{ Z}_{\text{S}} = \text{Z}_{\text{L}} = 50 \Omega; \\ \text{I}_{\text{C}} = 10 \text{ mA} $	-	2	-	dBm
IP3 _o	output third-order intercept point	f_1 = 12.000 GHz; f_2 = 12.025 GHz; V_{CE} = 2 V; Z_S = Z_L = 50 Ω ; I_C = 10 mA	-	12.5	-	dBm

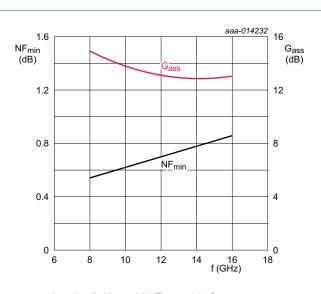
NPN wideband silicon germanium RF transistor

9.1 Graphs



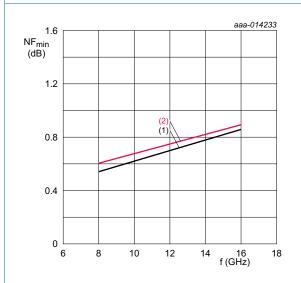
 $f = 12 \text{ GHz}; V_{CE} = 2 \text{ V}; T_{amb} = 25 \text{ }^{\circ}\text{C}.$

Fig 2. Minimum noise figure and associated gain as function of collector current; typical values



 I_C = 6 mA; V_{CE} = 2 V; T_{amb} = 25 °C.

Fig 3. Minimum noise figure and associated gain as function of frequency; typical values

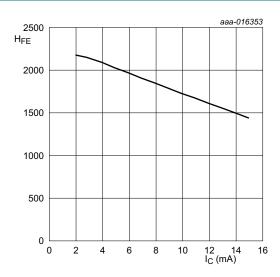


 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \,^{\circ}\text{C}.$

(1) $I_C = 6 \text{ mA}$

(2) $I_C = 10 \text{ mA}$





 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \,^{\circ}\text{C}.$

Fig 5. DC current gain as a function of collector current; typical values

NPN wideband silicon germanium RF transistor

10. Package outline

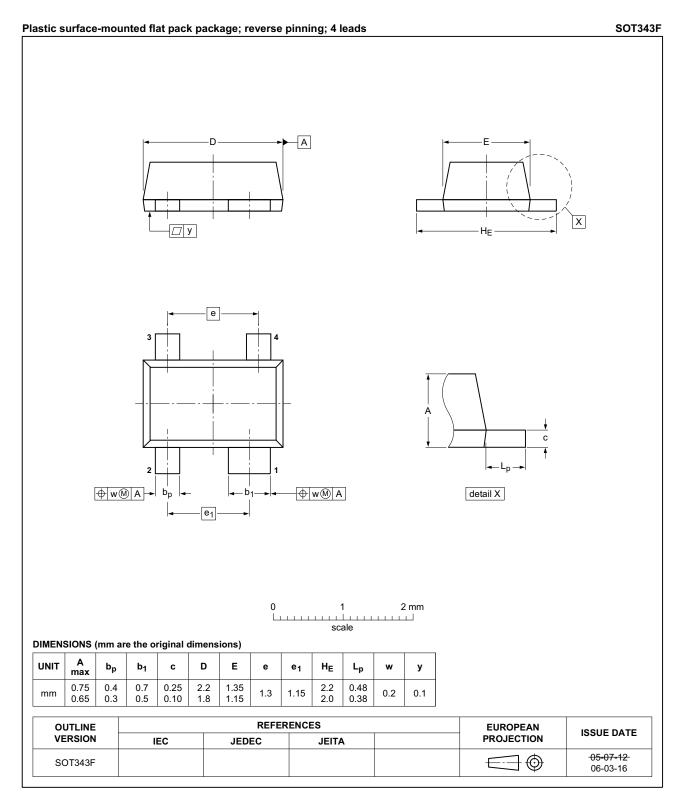


Fig 6. Package outline SOT343F

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NPN wideband silicon germanium RF transistor

11. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

12. Abbreviations

Table 10. Abbreviations

Acronym	Description
DBS	Direct Broadcast Satellite
K _u band	K-under band
NPN	Negative-Positive-Negative
SiGe	Silicon Germanium

13. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BFU910F v.2	20150116	Product data sheet	-	BFU910F v.1	
Modifications	 The title has Section 1.1 c Table 1 on pa Table 6 on pa 	 The status of this document has been changed to "Product data sheet". The title has been changed to "NPN wideband silicon germanium RF transistor". Section 1.1 on page 1: the wording of this section has been changed. Table 1 on page 1: Some changes have been made. Table 6 on page 3: The maximum value for V_{CE}, open base has been changed. 			
BFU910F v.1	Table 9 on pa	 Table 9 on page 4: the conditions for V_{(BR)CBO} and V_{(BR)CBO} have been changed. Figure 5 on page 6: the figure has been added. 			

NPN wideband silicon germanium RF transistor

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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NPN wideband silicon germanium RF transistor

16. Contents

1	Product profile
1.1	General description
1.2	Features and benefits
1.3	Applications
1.4	Quick reference data
2	Pinning information
3	Ordering information
4	Marking 2
5	Design support
6	Limiting values
7	Recommended operating conditions
8	Thermal characteristics
9	Characteristics
9.1	Graphs
10	Package outline
11	Handling information 8
12	Abbreviations 8
13	Revision history 8
14	Legal information 9
14.1	Data sheet status
14.2	Definitions 9
14.3	Disclaimers
14.4	Trademarks10
15	Contact information
16	Contents 11

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